AMENDMENTS TO THE CLAIMS

The following listing of claims will replace all prior versions and listings of claims in the application.

LISTING OF CLAIMS

- 1. (cancelled)
- 2. (currently amended) The probe of claim 4 4, wherein the optical detector is a photodiode or photodiode array.
- 3. (currently amended) The probe of claim 4 4, wherein the optical detector is a line-scan detector.
- 4. (currently amended) The probe of claim 1 An inspection probe for inspecting a surface finish of a machined surface, the probe comprising:

a laser directing a laser beam perpendicularly to the machined surface;

an optical detector positioned at an angle to the laser beam to detect
scattered laser light from the surface; and

a computer system including software that compares the detected scattered light to a scattered light signature from a first-type finishing mark and to a scattered light signature from a second-type finishing mark and determines a condition of the surface finish, wherein the machined surface is a cylinder bore for an engine block.

- 5. (original) The probe of claim 4, wherein the first-type finishing mark is coarser than the second-type finishing mark.
- 6. (original) The probe of claim 4, further comprising an optical device for directing the laser beam from the laser perpendicularly to the machined surface.
 - 7. (original) The probe of claim 6, wherein the optical device is a pentaprism.
- 8. (original) The probe of claim 6, wherein the laser and the optical device are supported inside a tube.
- 9. (original) The probe of claim 8, wherein the tube is mounted on a support shaft.
- 10. (original) The probe of claim 9, further comprising a power device transmitting power to the laser and the detector and transmitting data to a computer, the power device being mounted on the support shaft.
- 11. (original) The probe of claim 10, further comprising a detector electronics device mounted on the support shaft.
- 12. (original) The probe of claim 11, wherein the shaft is rotatably supported on a tool holder.

- 13. (original) The probe of claim 12, wherein the tool holder is supported on a spindle.
- 14. (original), The probe of claim 12, wherein the spindle is supported on a CNC machine.
- 15. (original) The probe of claim 14, wherein the CNC machine is programmed to sequentially inspect the cylinders of an engine block.
- 16. (original) The probe of claim 14, wherein the spindle is supported on a multi-probe inspection machine.
- 17. (original) The probe of claim 16, wherein the inspection machine is a reconfigurable inspection machine.
- 18. (original) The probe of claim 4, further comprising a filter in front of the detector to reduce unwanted light.
- 19. (original) The probe of claim 4, wherein each scattered light signature is distinguished by characteristic peaks of scattered light.
- 20. (original) The probe of claim 11, wherein the detector electronics device include signal amplification.

- 21. (original) The probe of claim 4, where the machined surface is metallic.
- 22. (canceled)
- 23. (currently amended) The method of claim 22-A method for inspecting the surface finish of a machined surface, the method comprising:

directing a laser beam perpendicularly to the machined surface;

detecting a scattered laser beam light from the machined surface;

determining a signature of the detected scattered laser beam light; and

determining a condition of the machined surface from the signature,

wherein the machined surface is a cylinder bore.

- 24. (original) The method of claim 23, wherein determining a signature includes determining a characteristic peak of the detected scattered laser beam light.
- 25. (original) The method of claim 23, wherein determining a condition includes determining a type of machining mark.
- 26. (original) The method of claim 24, wherein determining a signature includes comparing a scattered light signature from a first-type finishing mark to a scattered light signature from a second-type finishing mark.

27. (original) A reconfigurable inspection apparatus for inspecting the surface finish of a plurality of machined surfaces in a part, the inspection apparatus comprising:

a reconfigurable multi-spindle apparatus having a plurality of spindles;

a plurality of inspection probes rotatably and movably supported on corresponding spindles, each inspection probe comprising:

a laser that directs a laser beam perpendicularly to the machined surface;
a detector positioned at an angle to the laser beam to detect scattered
laser light from the surface; and

a computer system including software that compares the detected scattered light to a scattered light signature from a first-type finishing mark and to a scattered light signature from a second-type finishing mark and determines a condition of the surface finish.

- 28. (original) The inspection apparatus of claim 27, wherein the machined surfaces are cylinder bores and the part is an engine block.
- 29. (original) The inspection apparatus of claim 28, wherein the distance between any two inspection probes is changeable without removing the corresponding spindles from the inspection apparatus.
 - 30. (canceled)
 - 31. (canceled)

32. (currently amended) The inspection probe of claim 31 An inspection

probe for inspecting a surface finish of a manufactured surface, the probe comprising:

a laser directing a laser beam perpendicularly to the manufactured

surface;

an optical detector positioned at an angle to the laser beam to detect scattered laser light from the surface;

a computer system including software that compares the detected scattered light to a scattered light signature from a first-type finishing mark and to a scattered light signature from a second-type finishing mark and determines a condition of the surface finish, wherein the first and second finishing marks correspond to finishing marks before and after a removal of material.

33. (currently amended) The inspection probe of claim 31 An inspection

probe for inspecting a surface finish of a manufactured surface, the probe comprising:

a laser directing a laser beam perpendicularly to the manufactured

surface;

an optical detector positioned at an angle to the laser beam to detect scattered laser light from the surface;

a computer system including software that compares the detected scattered light to a scattered light signature from a first-type finishing mark and to a scattered light signature from a second-type finishing mark and determines a condition of the surface finish, wherein the first and second finishing marks correspond to finishing marks before and after an addition of material.